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<0.5 Ω CMOS, Low Voltage, SPST Switches

ADG801/ADG802

FEATURES

Low On Resistance < 0.5 Ω max at 5 V supply
 0.1 Ω On Resistance Flatness
 +1.8 V to +5.5 V Single Supply
 100pA Leakage Currents
 14ns Switching Times
 Extended Temperature Range -40°C to +125°C
 High Current Carrying Capability
 Tiny 6 lead SOT23 and 8 Lead μ SOIC Packages
 Low Power Consumption
 TTL/CMOS Compatible Inputs
 Pin Compatible with ADG701/ADG702

APPLICATIONS

Power Routing
 Audio and Video Signal Routing
 Cellular Phones
 Modems
 PCMCIA Cards
 Hard Drives
 Data Acquisition Systems
 Communication Systems
 Relay replacement
 Audio and Video Switching
 Battery Powered Systems

GENERAL DESCRIPTION

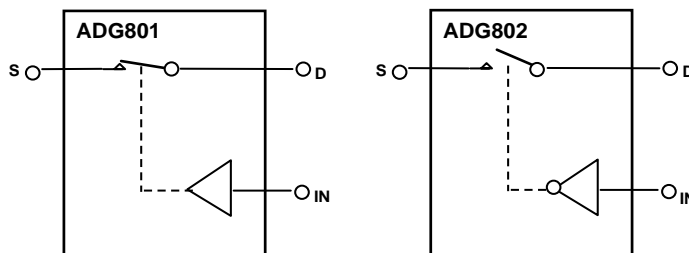
The ADG801/ADG802 are monolithic CMOS SPST (Single Pole, Single Throw) switches with On Resistance of less than 0.5 Ω . These switches are designed on an advanced submicron process that provides extremely low on resistance, high switching speed and low leakage currents.

The low On Resistance of <0.5 Ω means these parts are ideal for applications where low on resistance switching is critical.

The ADG801 is a normally open (NO) switch, while the ADG802 is normally closed (NC). Each switch conducts equally well in both directions when ON.

The ADG801 and ADG802 are available in 6-lead SOT-23 and 8 Lead μ SOIC packages.

FUNCTIONAL BLOCK DIAGRAMS



SWITCHES SHOWN FOR A LOGIC "1" INPUT

PRODUCT HIGHLIGHTS

1. Low On Resistance (0.25 Ω typical).
2. +1.8V to +5.5V Single Supply Operation.
3. Tiny 6 Lead SOT23 and 8 Lead μ SOIC Packages.
4. Pin Compatible with ADG701 (ADG801)
Pin Compatible with ADG702 (ADG802).

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One Technology Way, P.O.Box 9106, Norwood, MA 02062-9106, U.S.A.
 Tel: 781/329-4700 www.analog.com
 Fax: 781/326-8703 © Analog Devices, Inc., 2002

ADG801/ADG802–SPECIFICATIONS¹(V_{DD} = 5 V ±10%, V_{SS} = GND = 0 V. All specifications –40°C to +125°C unless otherwise noted.)

Parameter	+25°C	–40°C to +85°C	–40°C to +125°C	Units	Test Conditions/Comments
ANALOG SWITCH					
Analog Signal Range			0 V to V _{DD}	V	V _S = 0 V to V _{DD} , I _S = –10 mA; Test Circuit 1 V _S = 0 V to V _{DD} , I _S = –10 mA
On Resistance (R _{ON})	0.25			Ω typ	
	0.4	0.5	0.75	Ω max	
On-Resistance Flatness (R _{FLAT(ON)})	0.05			Ω typ	
		0.1	0.2	Ω max	
LEAKAGE CURRENTS					
Source OFF Leakage I _S (OFF)	±0.01			nA typ	V _{DD} = +5.5 V
	±0.5	±1	tbd	nA max	V _S = 4.5 V/1 V, V _D = 1 V/4.5 V; Test Circuit 2
Drain OFF Leakage I _D (OFF)	±0.01			nA typ	V _S = 4.5 V/1 V, V _D = 1 V/4.5 V;
	±0.5	±1	tbd	nA max	Test Circuit 2
Channel ON Leakage I _D , I _S (ON)	±0.01			nA typ	V _S = V _D = 1 V, or 4.5 V;
	±0.5	±1	tbd	nA max	Test Circuit 3
DIGITAL INPUTS					
Input High Voltage, V _{INH}			2.4	V min	V _{IN} = V _{INL} or V _{INH}
Input Low Voltage, V _{INL}			0.8	V max	
Input Current I _{INL} or I _{INH}	0.005			μA typ	
			±0.1	μA max	
C _{IN} , Digital Input Capacitance	5			pF typ	
DYNAMIC CHARACTERISTICS²					
t _{ON}	30			ns typ	R _L = 50 Ω, C _L = 35 pF V _S = 3 V; Test Circuit 4
	TBD		TBD	ns max	
t _{OFF}	20			ns typ	R _L = 50 Ω, C _L = 35 pF V _S = 3 V; Test Circuit 4
	TBD		TBD	ns max	
Charge Injection	±20			pC typ	V _S = 0 V, R _S = 0 Ω, C _L = 1 nF, Test Circuit 5
Off Isolation	–65			dB typ	R _L = 50 Ω, C _L = 5 pF, f = 1 MHz, Test Circuit 6
Bandwidth –3 dB	30			MHz typ	R _L = 50 Ω, C _L = 5 pF, Test Circuit 7
C _S (OFF)	55			pF typ	f = 1 MHz
C _D (OFF)	55			pF typ	f = 1 MHz
C _D , C _S (ON)	110			pF typ	f = 1 MHz
POWER REQUIREMENTS					
I _{DD}	0.001			μA typ	V _{DD} = +5.5 V
			1.0	μA max	Digital Inputs = 0 V or 5.5 V

NOTES

¹Temperature ranges are as follows: Extended Temperature Range: –40°C to +125°C.²Guaranteed by design, not subject to production test.

Specifications subject to change without notice.

SPECIFICATIONS¹

($V_{DD} = 2.7\text{ V to }3.6\text{ V}$, $V_{SS} = \text{GND} = 0\text{ V}$. All specifications $-40^{\circ}\text{C to }+125^{\circ}\text{C}$ unless otherwise noted.)

Parameter	+25°C	-40°C to +85°C	-40°C to +125°C	Units	Test Conditions/Comments
ANALOG SWITCH					
Analog Signal Range			0 V to V_{DD}	V	
On Resistance (R_{ON})	0.3		1	Ω typ	$V_S = 0\text{ V to }V_{DD}$, $I_S = -10\text{ mA}$; Test Circuit 1
On-Resistance Flatness($R_{FLAT(ON)}$)	0.7	0.8		Ω max	
	0.1		0.3	Ω typ	$V_S = 0\text{ V to }V_{DD}$, $I_S = -10\text{ mA}$
LEAKAGE CURRENTS					
Source OFF Leakage I_S (OFF)	± 0.01			nA typ	$V_{DD} = +3.3\text{ V}$ $V_S = 3\text{ V}/1\text{ V}$, $V_D = 1\text{ V}/3\text{ V}$; Test Circuit 2
	± 0.5	± 0.1	tbd	nA max	
Drain OFF Leakage I_D (OFF)	± 0.01			nA typ	$V_S = 3\text{ V}/1\text{ V}$, $V_D = 1\text{ V}/3\text{ V}$; Test Circuit 2
	± 0.5	± 0.1	tbd	nA max	
Channel ON Leakage I_D , I_S (ON)	± 0.01			nA typ	$V_S = V_D = 1\text{ V}$, or 3 V ; Test Circuit 3
	± 0.5	± 0.1	tbd	nA max	
DIGITAL INPUTS					
Input High Voltage, V_{INH}			2.0	V min	
Input Low Voltage, V_{INL}			0.4	V max	
Input Current I_{INL} or I_{INH}	0.005			μA typ	$V_{IN} = V_{INL}$ or V_{INH}
			± 0.1	μA max	
C_{IN} , Digital Input Capacitance	5			pF typ	
DYNAMIC CHARACTERISTICS²					
t_{ON}	50			ns typ	$R_L = 50\ \Omega$, $C_L = 35\text{ pF}$ $V_S = 1.5\text{ V}$, Test Circuit 4
	TBD		TBD	ns max	
t_{OFF}	40			ns typ	$R_L = 50\ \Omega$, $C_L = 35\text{ pF}$ ns max $V_S = 1.5\text{ V}$, Test Circuit 4
	TBD		TBD		$V_S = 0\text{ V}$, $R_S = 0\ \Omega$, $C_L = 1\text{ nF}$, Test Circuit 5
Charge Injection	± 20			pC typ	
Off Isolation	-65			dB typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$, $f = 1\text{ MHz}$, Test Circuit 6
Bandwidth -3 dB	30			MHz typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$, Test Circuit 7
C_S (OFF)	55			pF typ	$f = 1\text{ MHz}$
C_D (OFF)	55			pF typ	$f = 1\text{ MHz}$
C_D , C_S (ON)	110			pF typ	$f = 1\text{ MHz}$
POWER REQUIREMENTS					
I_{DD}	0.001			μA typ	$V_{DD} = +3.3\text{ V}$ Digital Inputs = 0 V or 3.3 V
			1.0	μA max	

NOTES¹Temperature ranges are as follows: Extended Temperature Range: $-40^{\circ}\text{C to }+125^{\circ}\text{C}$.²Guaranteed by design, not subject to production test.

Specifications subject to change without notice.

ADG801/ADG802

ABSOLUTE MAXIMUM RATINGS¹

(T_A = +25°C unless otherwise noted)

V _{DD} to GND	-0.3 V to +7 V
Analog Inputs ²	-0.3 V to V _{DD} +0.3 V
	or 30 mA, Whichever Occurs First
Continuous Current, S or D	400 mA
Peak Current, S or D	800 mA
	(Pulsed at 1 ms, 10% Duty Cycle Max)
Operating Temperature Range	
Extended	-40°C to +125°C
Storage Temperature Range	-65°C to +150°C
Junction Temperature	+150°C
μSOIC Package, Power Dissipation	315 mW
θ _{JA} Thermal Impedance	206°C/W
θ _{JC} Thermal Impedance	44°C/W
SOT-23 Package, Power Dissipation	282 mW
θ _{JA} Thermal Impedance	229.6°C/W
θ _{JC} Thermal Impedance	91.99°C/W
Lead Temperature, Soldering (10seconds)	300°C
IR Reflow, Peak Temperature	+220°C
ESD	2kV

NOTES

¹Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those listed in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Only one absolute maximum rating may be applied at any one time.

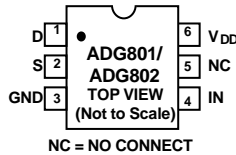
²Overvoltages at IN, S or D will be clamped by internal diodes. Current should be limited to the maximum ratings given.

Table I. Truth Table

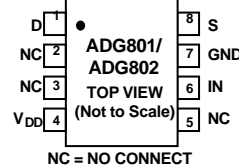
ADG801 In	ADG802 In	Switch Condition
0	1	OFF
1	0	ON

PIN CONFIGURATIONS

6-Lead Plastic Surface Mount (SOT-23)
(RT-6)



8-Lead Small Outline μSOIC
(RM-8)



ORDERING GUIDE

Model	Temperature Range	Supply Option ¹	Brand ¹	Package Descriptions	Package Options
ADG801BRT	-40°C to +125°C	3 V, 5 V	SLB	SOT-23 (Plastic Surface Mount)	RT-6
ADG801BRM	-40°C to +125°C	3 V, 5 V	SLB	μSOIC (Small Outline)	RM-8
ADG802BRT	-40°C to +125°C	3 V, 5 V	SMB	SOT-23 (Plastic Surface Mount)	RT-6
ADG802BRM	-40°C to +125°C	3 V, 5 V	SMB	μSOIC (Small Outline)	RM-8

¹Branding on SOT-23 and μSOIC packages is limited to 3 characters due to space constraints.

CAUTION

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although the ADG801/ADG802 features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.



TERMINOLOGY

V_{DD}	Most positive power supply potential.
I_{DD}	Positive supply current.
GND	Ground (0 V) reference.
S	Source terminal. May be an input or output.
D	Drain terminal. May be an input or output.
IN	Logic control input.
$V_D (V_S)$	Analog voltage on terminals D, S
R_{ON}	Ohmic resistance between D and S.
$R_{FLAT(ON)}$	Flatness is defined as the difference between the maximum and minimum value of on-resistance as measured over the specified analog signal range.
$I_S (OFF)$	Source leakage current with the switch "OFF."
$I_D (OFF)$	Drain leakage current with the switch "OFF."
$I_D, I_S (ON)$	Channel leakage current with the switch "ON."
V_{INL}	Maximum input voltage for logic "0".
V_{INH}	Minimum input voltage for logic "1".
$I_{INL} (I_{INH})$	Input current of the digital input.
$C_S (OFF)$	"OFF" switch source capacitance. Measured with reference to ground.
$C_D (OFF)$	"OFF" switch drain capacitance. Measured with reference to ground.
$C_D, C_S (ON)$	"ON" switch capacitance. Measured with reference to ground.
C_{IN}	Digital input capacitance.
t_{ON}	Delay between applying the digital control input and the output switching on. See Test Circuit 4.
t_{OFF}	Delay between applying the digital control input and the output switching off.
Charge Injection	A measure of the glitch impulse transferred from the digital input to the analog output during switching.
Off Isolation	A measure of unwanted signal coupling through an "OFF" switch.
Crosstalk	A measure of unwanted signal which is coupled through from one channel to another as a result of parasitic capacitance.
Bandwidth	The frequency at which the output is attenuated by 3dBs.
On Response	The Frequency response of the "ON" switch.
Insertion Loss	The loss due to the ON resistance of the switch.

ADG801/ADG802

TYPICAL PERFORMANCE CHARACTERISTICS

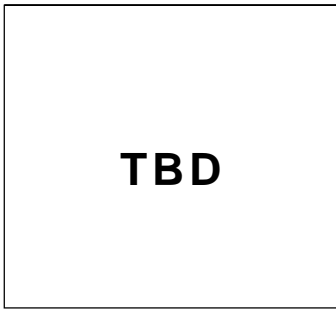


Figure 1. On Resistance as a Function of $V_D(V_S)$

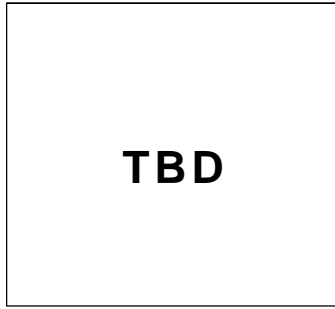


Figure 4. Leakage Currents as a function of $V_D(V_S)$

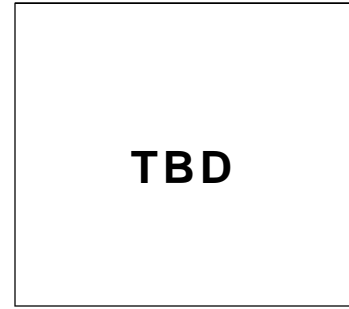


Figure 7. Leakage Currents as a Function of Temperature

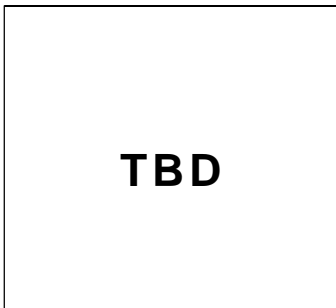


Figure 2. On Resistance as a Function of $V_D(V_S)$ for Different Temperatures

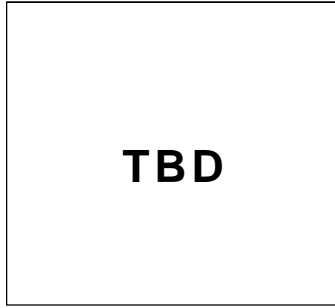


Figure 5. Leakage Currents as a function of $V_D(V_S)$

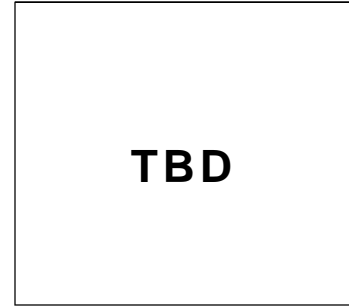


Figure 8. Supply Currents vs. Input Switching Frequency

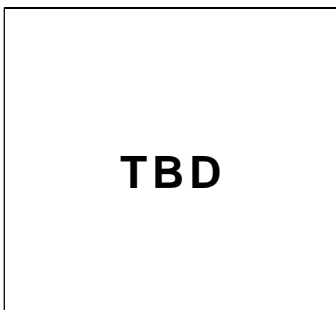


Figure 3. On Resistance as a Function of $V_D(V_S)$ for Different Temperatures

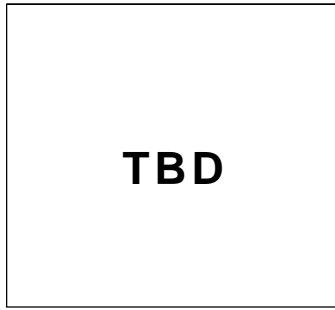


Figure 6. Leakage Currents as a function of Temperature

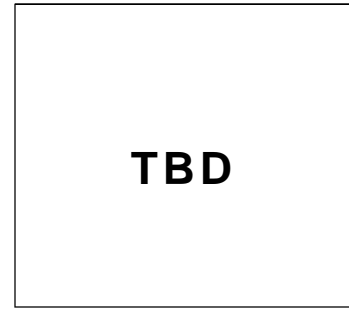


Figure 9. Charge Injection vs. Source Voltage

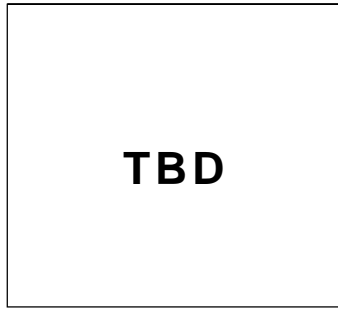


Figure 10. T_{ON}/T_{OFF} Times vs. Temperature

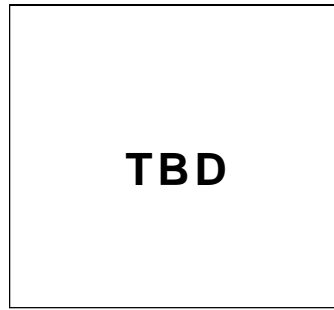


Figure 13. On Response vs. Frequency

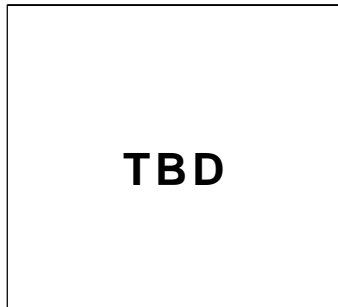


Figure 11. Off Isolation vs. Frequency

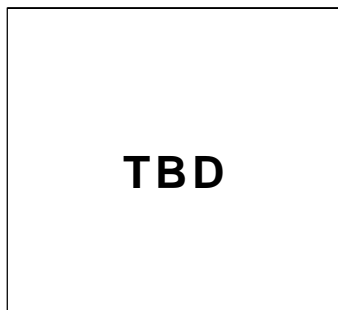
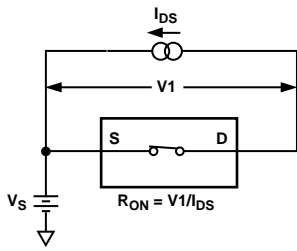


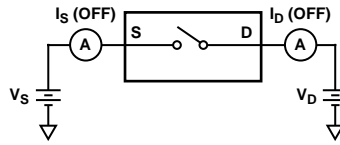
Figure 12. Crosstalk vs. Frequency

ADG801/ADG802

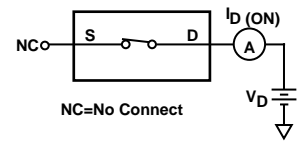
Test Circuits



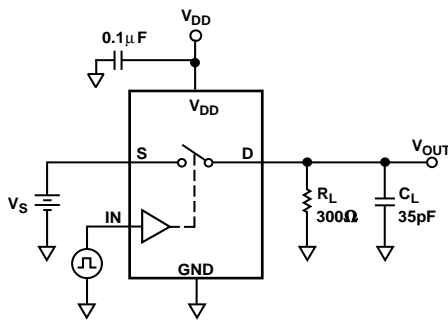
Test Circuit 1. On Resistance



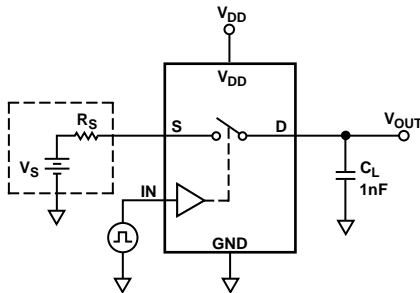
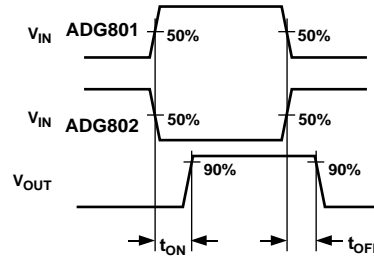
Test Circuit 2. Off Leakage



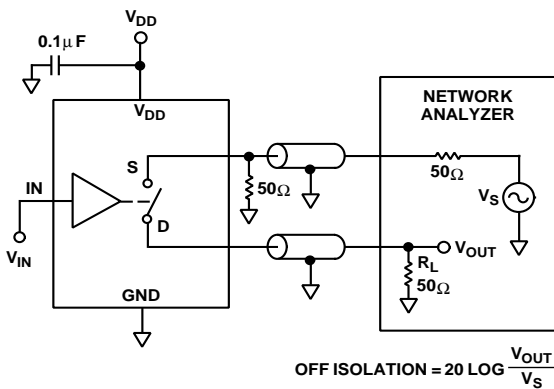
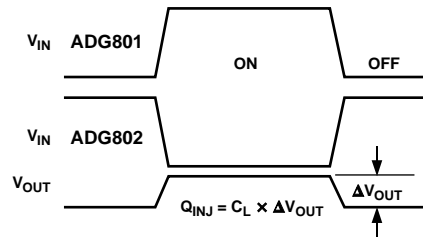
Test Circuit 3. On Leakage



Test Circuit 4. Switching Times

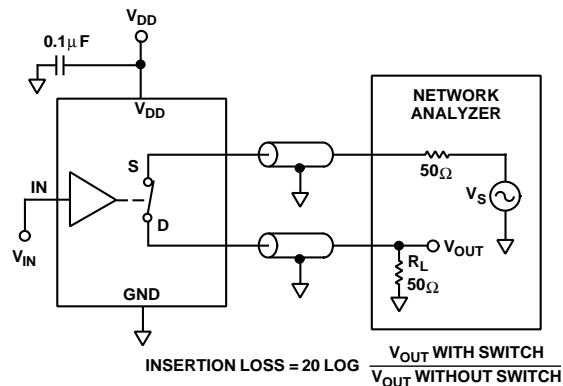


Test Circuit 5. Charge Injection



$$\text{OFF ISOLATION} = 20 \text{ LOG} \frac{V_{\text{OUT}}}{V_S}$$

Test Circuit 6. Off Isolation



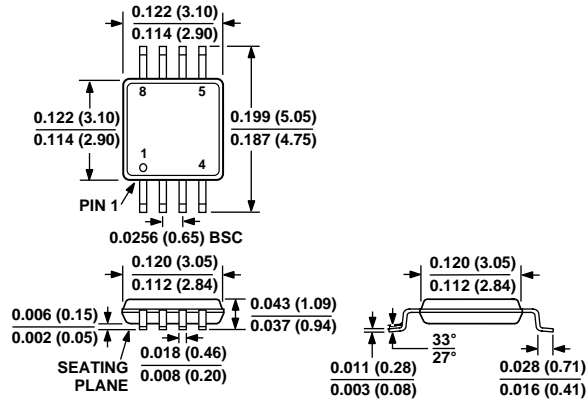
$$\text{INSERTION LOSS} = 20 \text{ LOG} \frac{V_{\text{OUT WITH SWITCH}}}{V_{\text{OUT WITHOUT SWITCH}}}$$

Test Circuit 7. Bandwidth

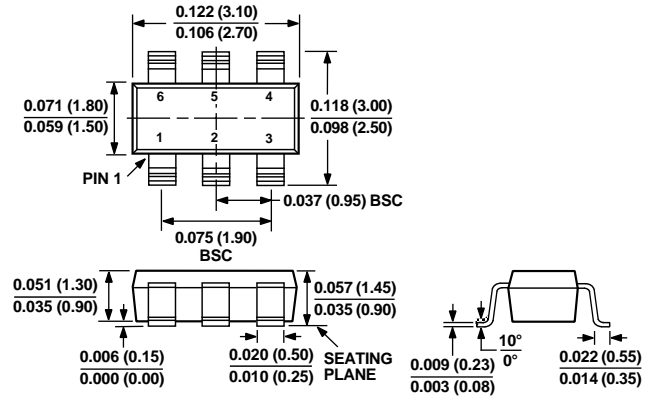
OUTLINE DIMENSIONS

Dimensions shown in inches and (mm).

8-Lead μ SOIC
(RM-8)



6-Lead SOT-23
(RT-6)





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